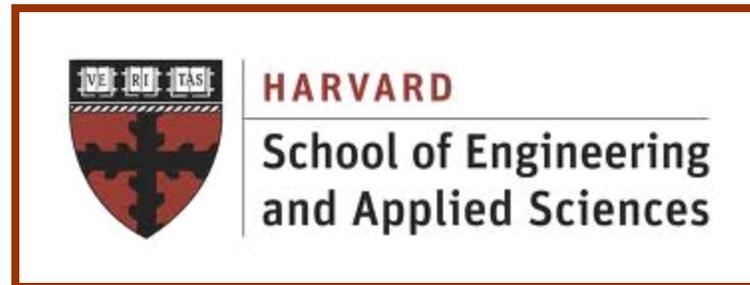


Making Sense of Claims of SI Traceability

John A. Dykema, James G. Anderson

dykema@fas.harvard.edu

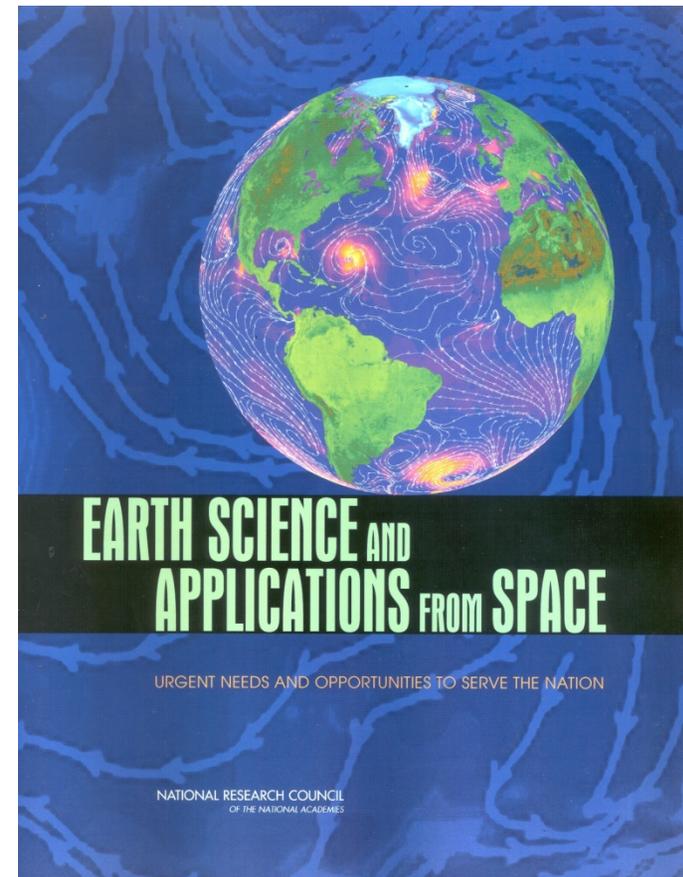


VISION

*A healthy, secure, prosperous
and sustainable society for
all people on Earth*

*“The United States does not have, nor are there clear plans to develop, a long-term global benchmark record of critical climate variables that are accurate over very long time periods, can be tested for **systematic errors** by future generations, are unaffected by interruption, and are pinned to international standards.”*

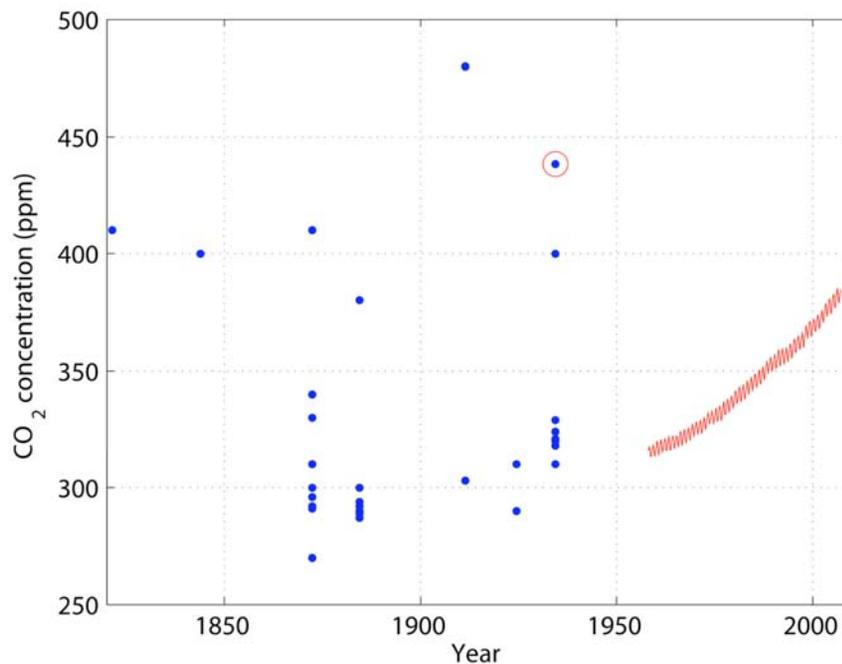
NRC



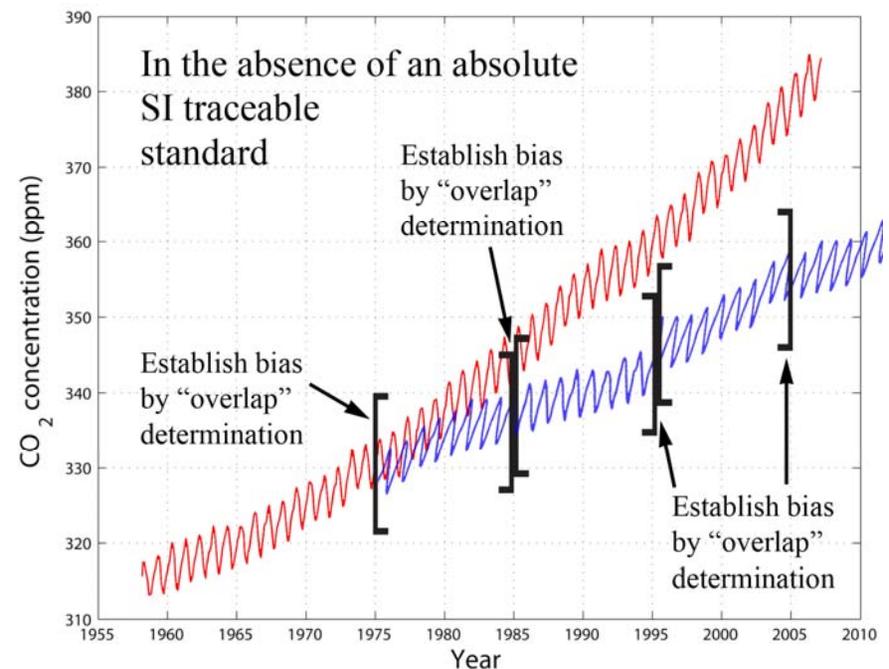
Systematic Errors?

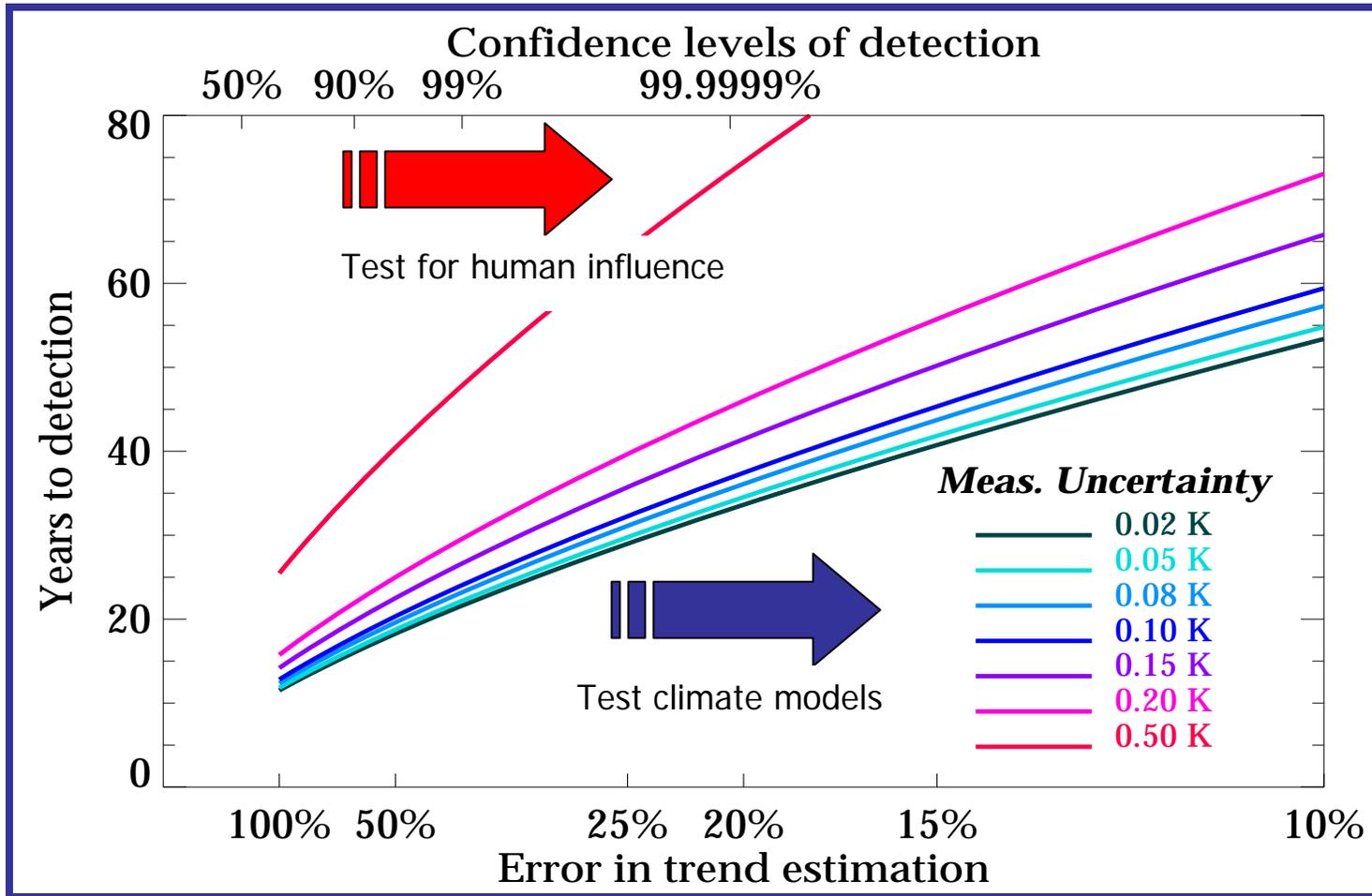
- “Bias” in the language of metrological science
- Accuracy vs. precision

Historical CO₂ Data



Slocum, 1955 - NOAA Global Monitoring Division





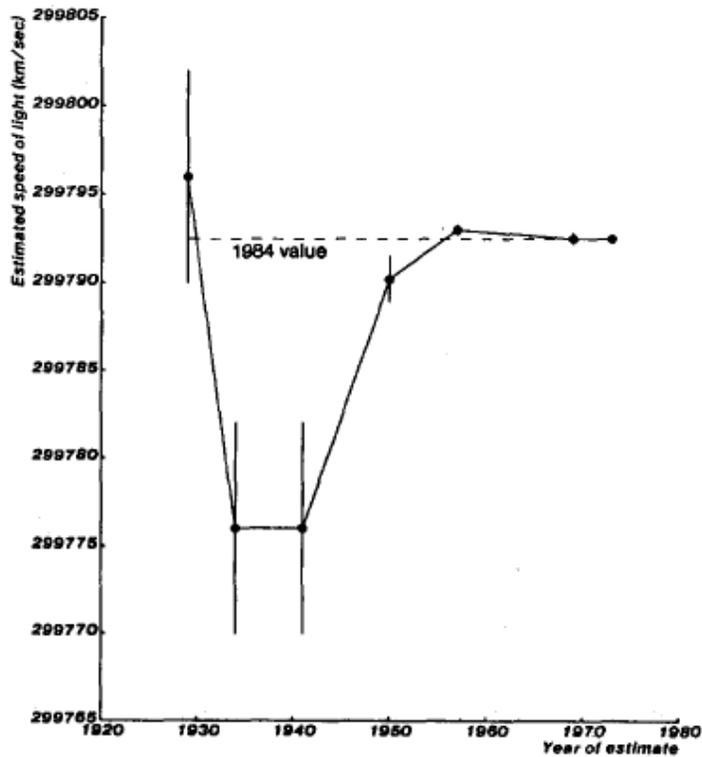
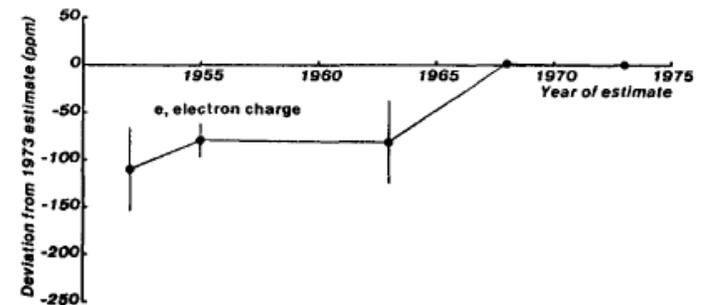
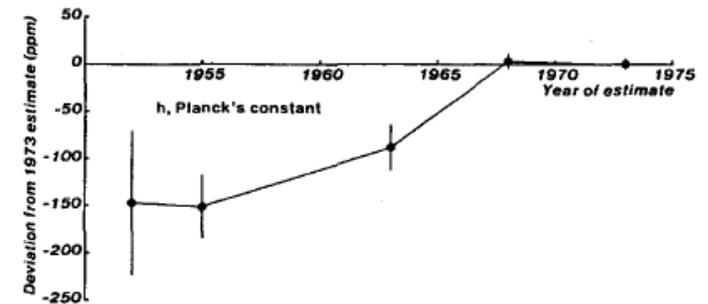
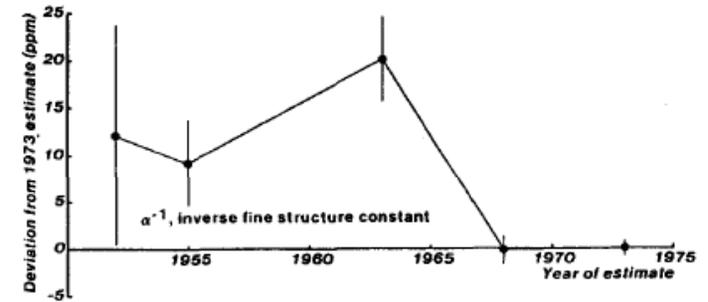


Fig. 2. Recommended values for the velocity of light; 1929–1973.

*from Henrion and Fischhoff,
1986, Am. J. Phys.*



What is “traceability”?

*The property of the result of a measurement or the value of a standard whereby it can be **related to stated references**, usually national or international standards, through an **unbroken chain** of comparisons all having **stated uncertainties**.*

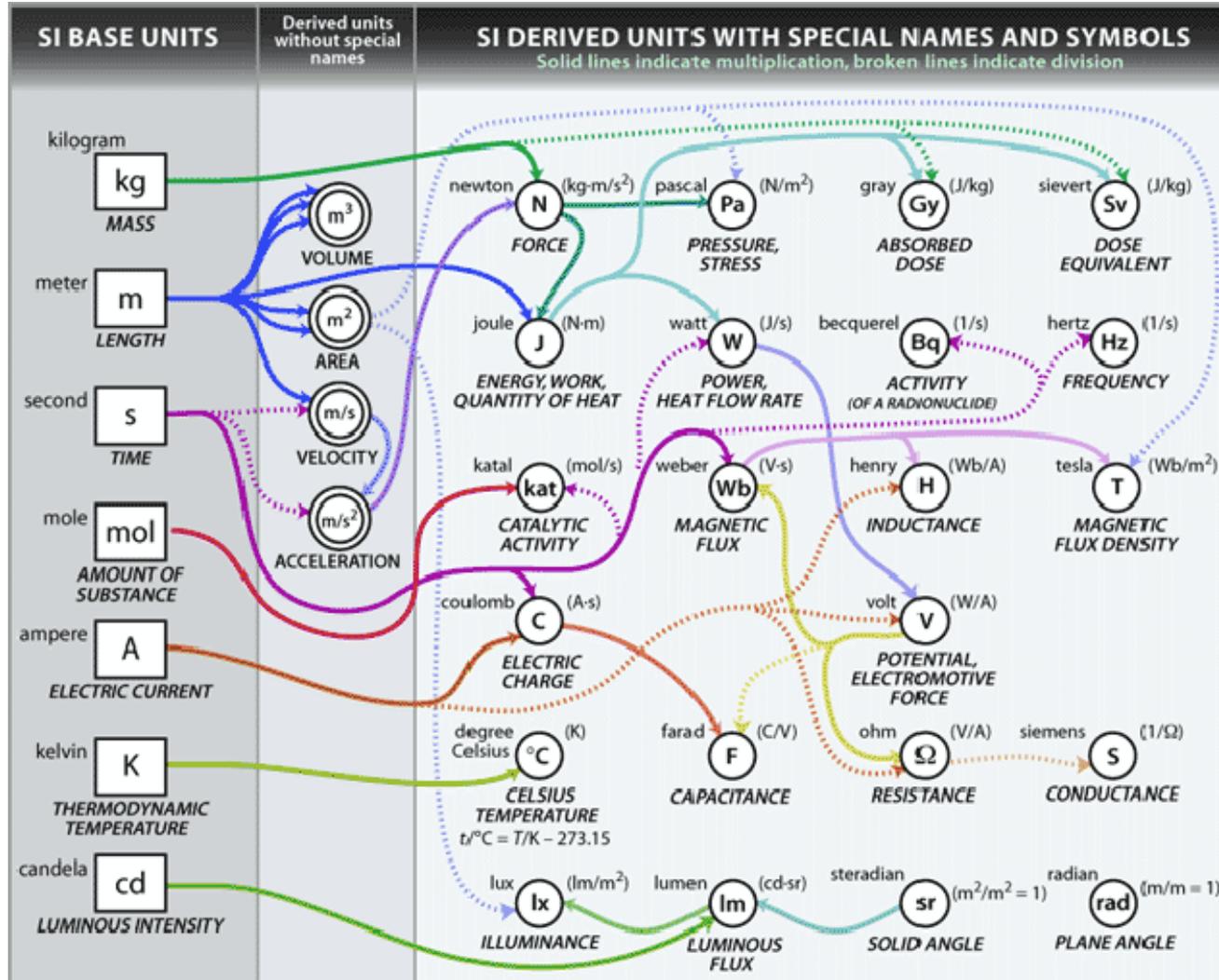
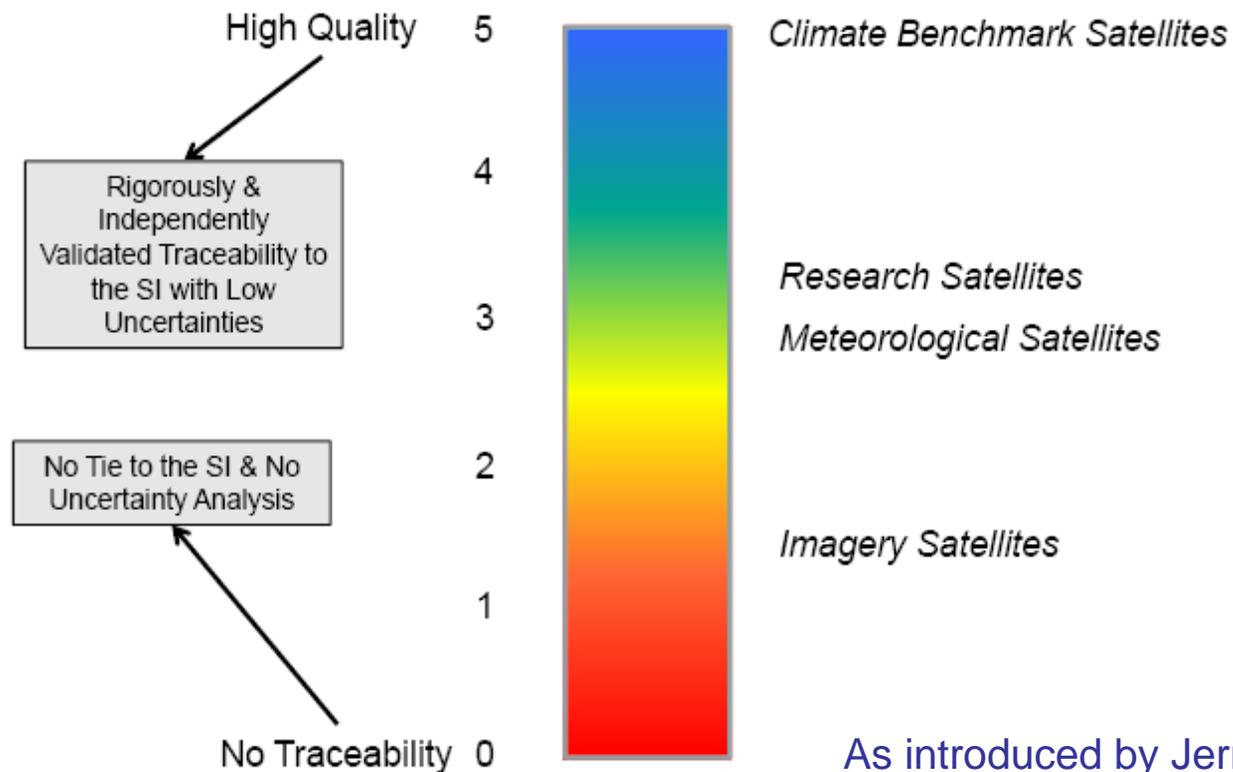


Figure courtesy Eric Shirley

Quality of Traceability Claim

Quality of Traceability Claim for Radiances



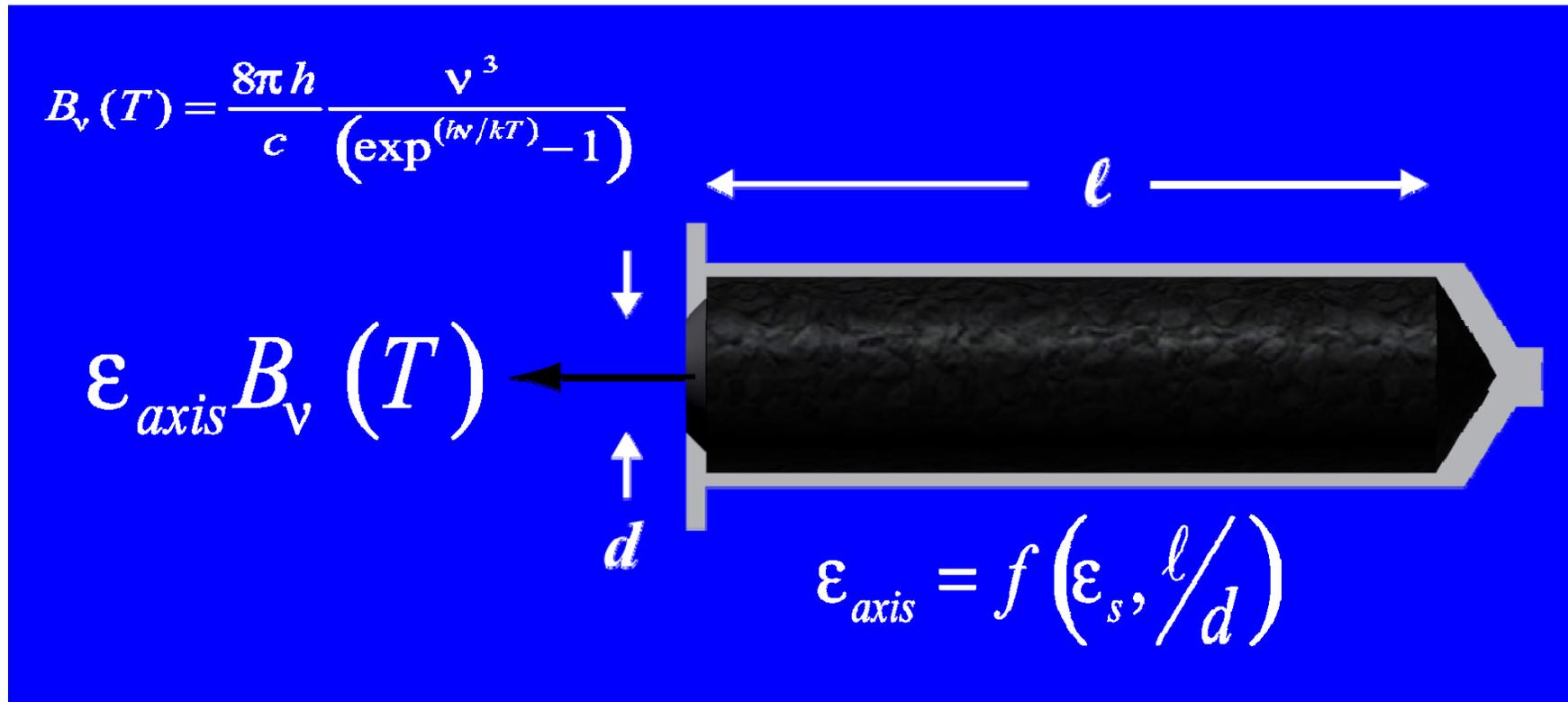


Anticipating Congressional hearings

- What disciplines of natural sciences will be represented?
- What methods for assessing instrument accuracy will be most credible?

SI Traceability for Remote Sensing

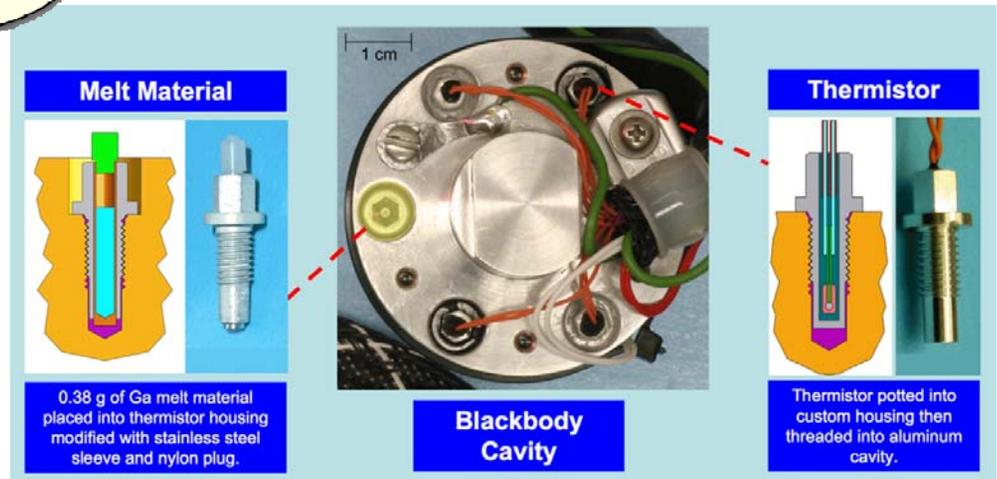
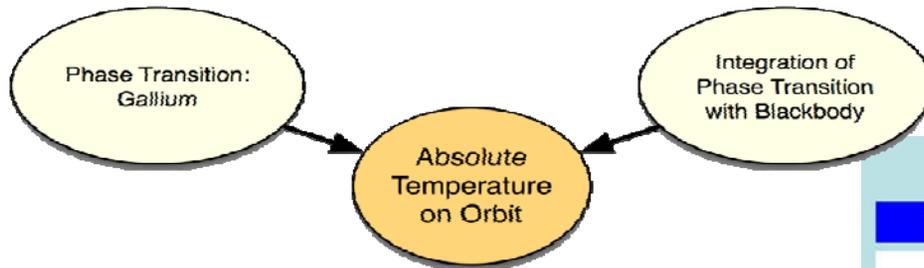
- Fox, 1999, *Adv. Space Res.*
- Pollock et al., 2001, *Metrologia*
- Dykema and Anderson, 2006, *Metrologia*
- Dykema, Shirley, Fraser and Anderson, in preparation for *IEEE Trans. Geosci. Rem. Sens.*



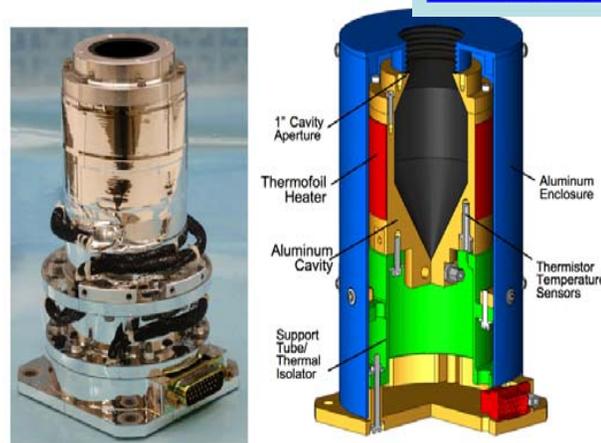
On-Orbit Blackbody:

- Finite Aperture
- Temperature Gradient

Dykema and Anderson,
Metrologia **43** 287 (2006)

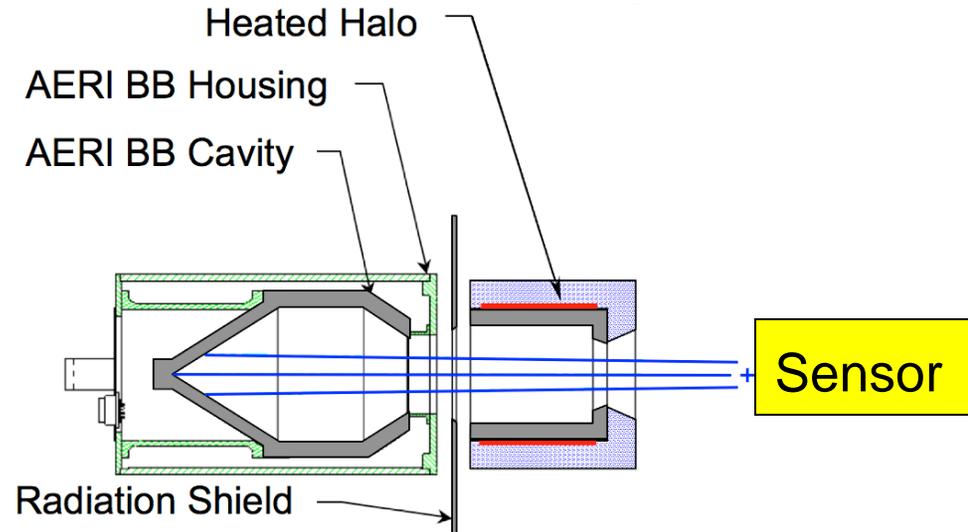


| Key Parameter | Specification | As Delivered |
|---------------------------|-----------------------|--------------|
| Measurement Range | 233 to 313 K | 233 to 313 K |
| Temperature Uncertainty | < 0.1 K (3 σ) | < 0.056 K |
| Blackbody Emissivity | > 0.996 | > 0.999 |
| Emissivity Uncertainty | < 0.002 (3 σ) | < 0.00072 |
| Entrance Aperture | 1.0 inch | 1.0 inch |
| Mass (2 BBs + controller) | < 2.4 kg | 2.1 kg |
| Power (average/max) | < 2.2/5.2 W | 2.2/5.2 W |

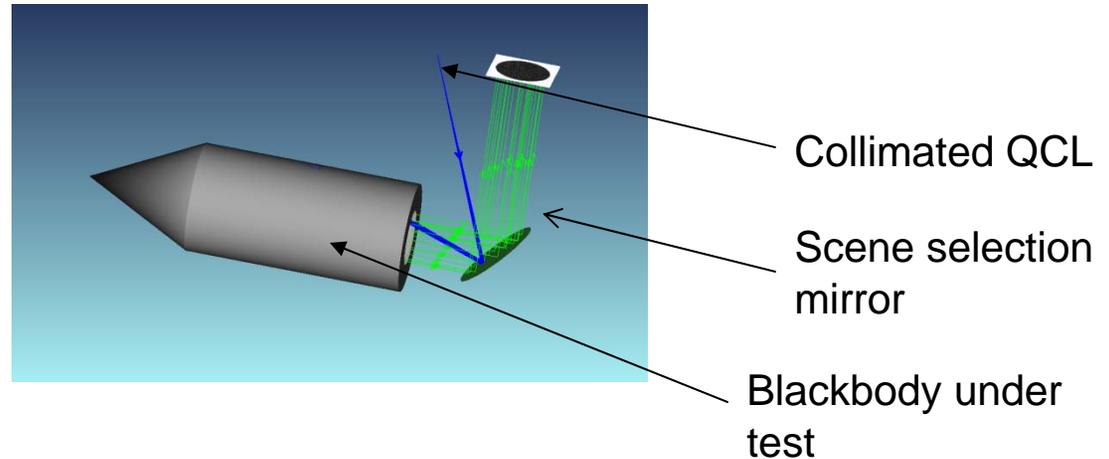


Technology developed by UW-SSEC under IIP

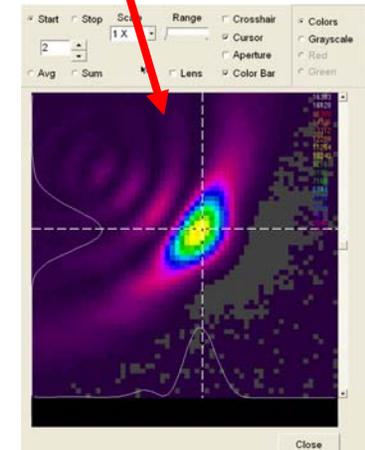
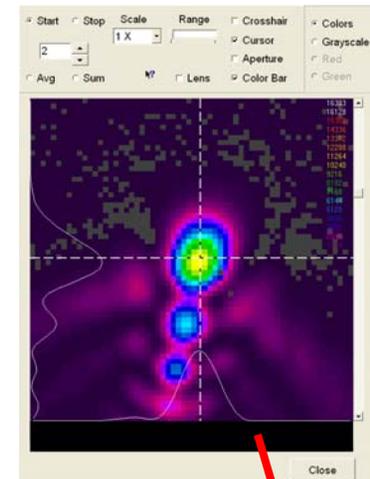
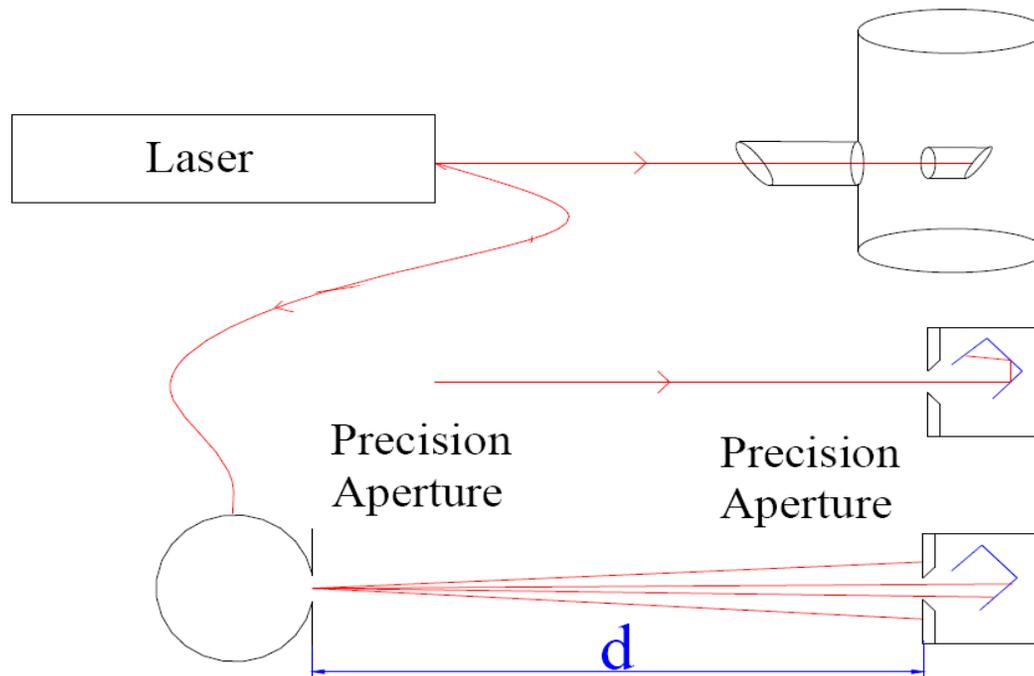
OCEM-Halo:
Measures
hemispheric
normal emissivity



OCEM-QCL: Direct
measurement of
directional-normal
reflectivity

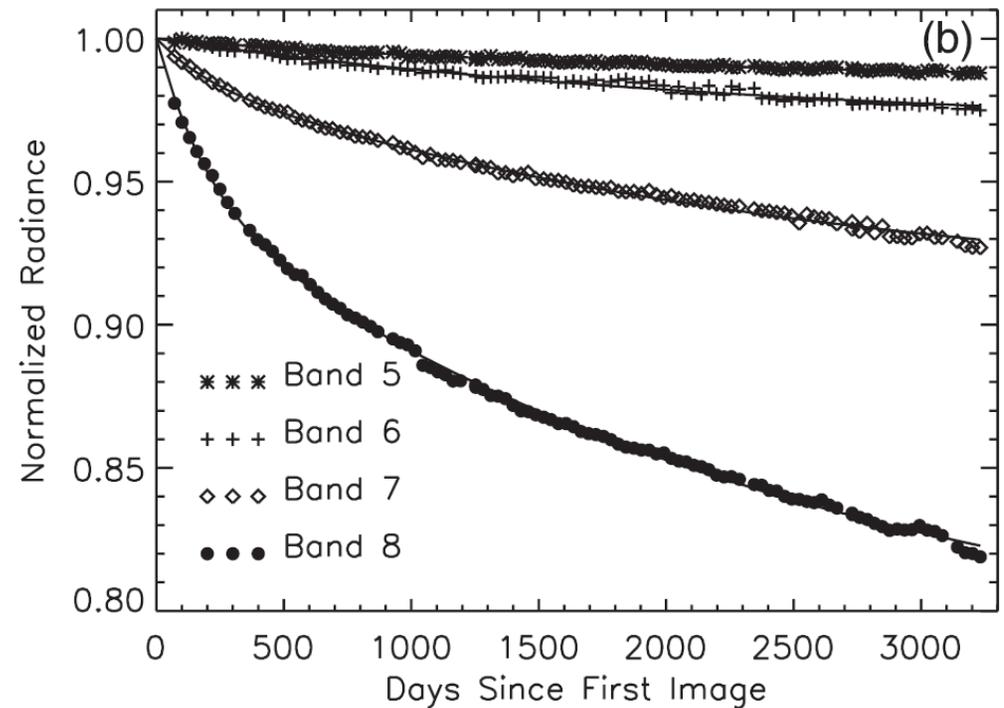


Confounding Factors 1: Measurement Conditions

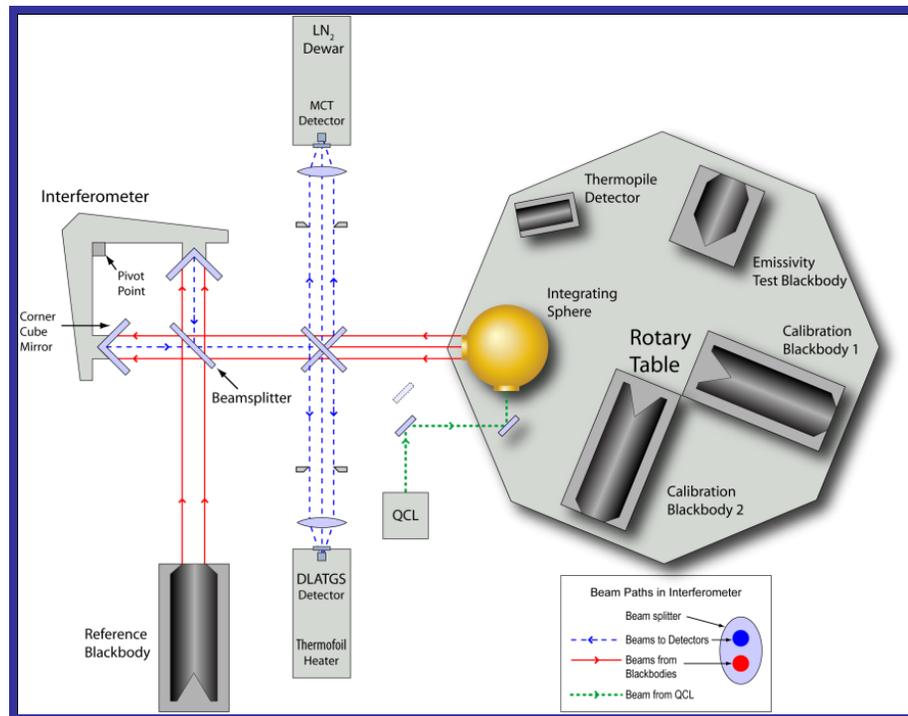


Confounding Factors 2: Aging and Exposure

LDEF

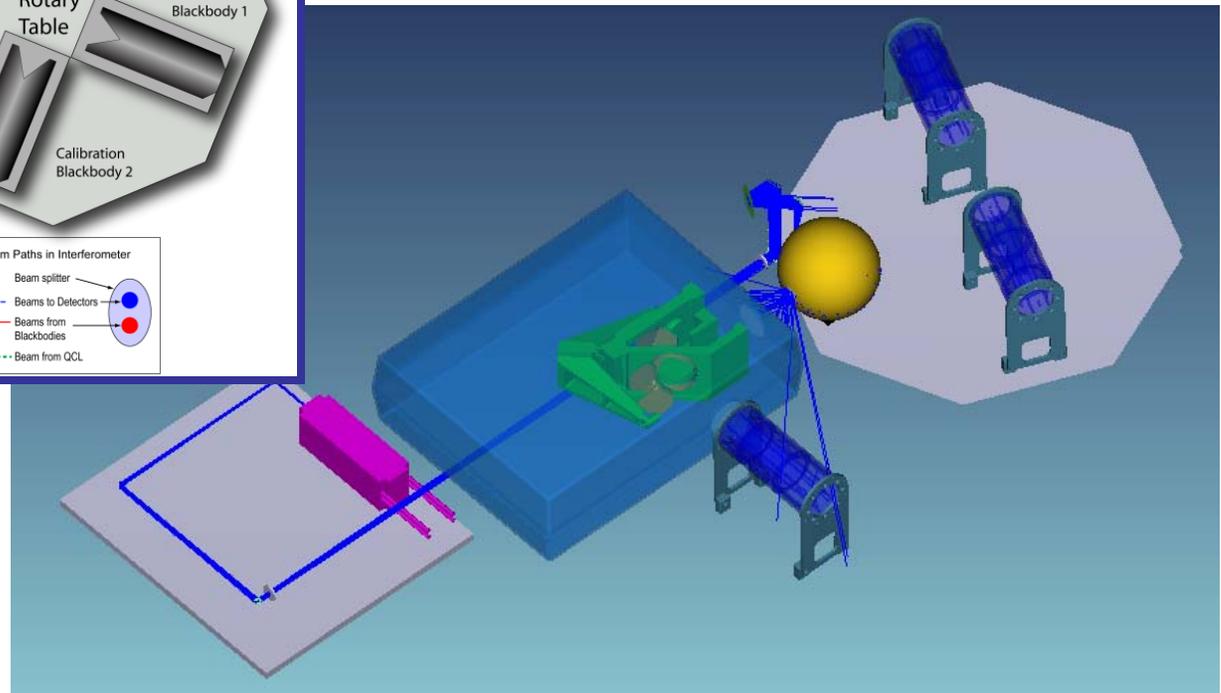


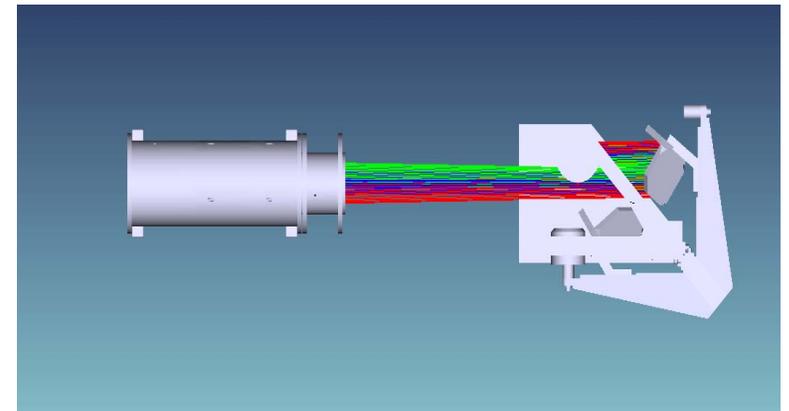
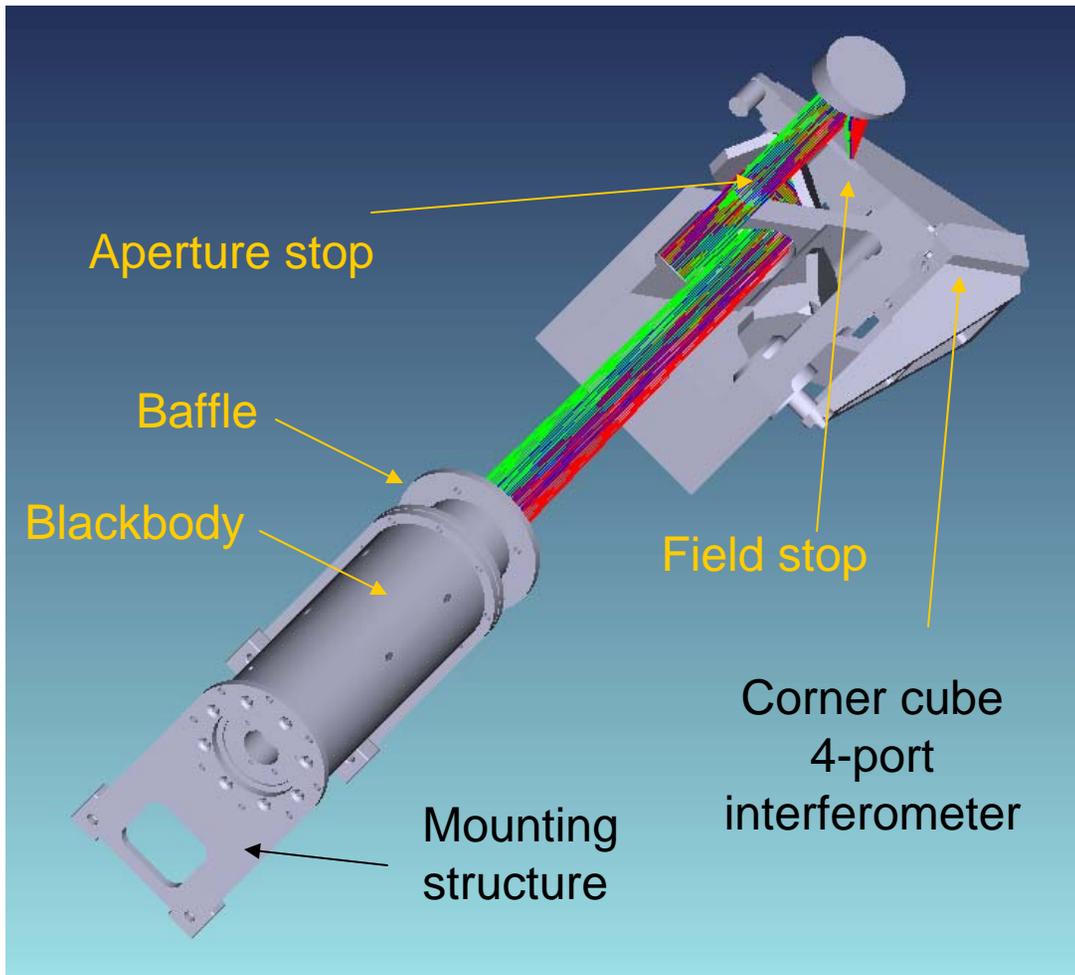
Lunar calibration of SeaWiFS diffuser shows degradation over time (Eplee et al. 2007 *App. Opt.*)



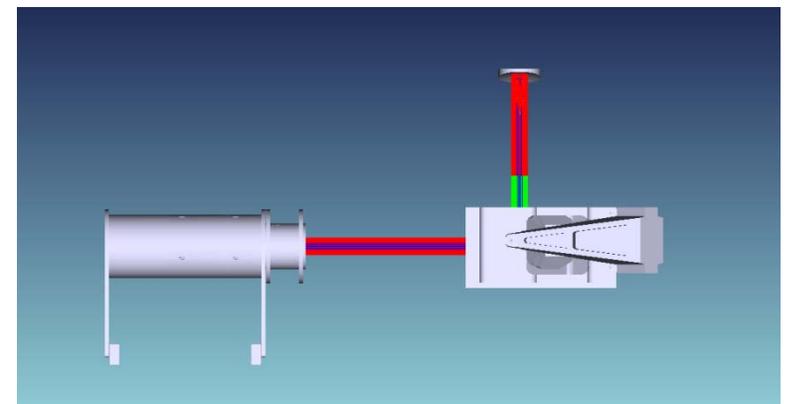
DARI-LW
testbed

1. Gero, PJ; Dykema, JA.; Anderson, JG, 2008: A Blackbody Design for SI-Traceable Radiometry for Earth Observation, *J.Tech.* **25**(11) 2046
2. Gero, PJ; Dykema, JA.; Anderson, JG, 2009: A Quantum Cascade Laser-Based Reflectometer for On-Orbit Blackbody Cavity Monitoring, *J.Tech.* **26**(8) 1596

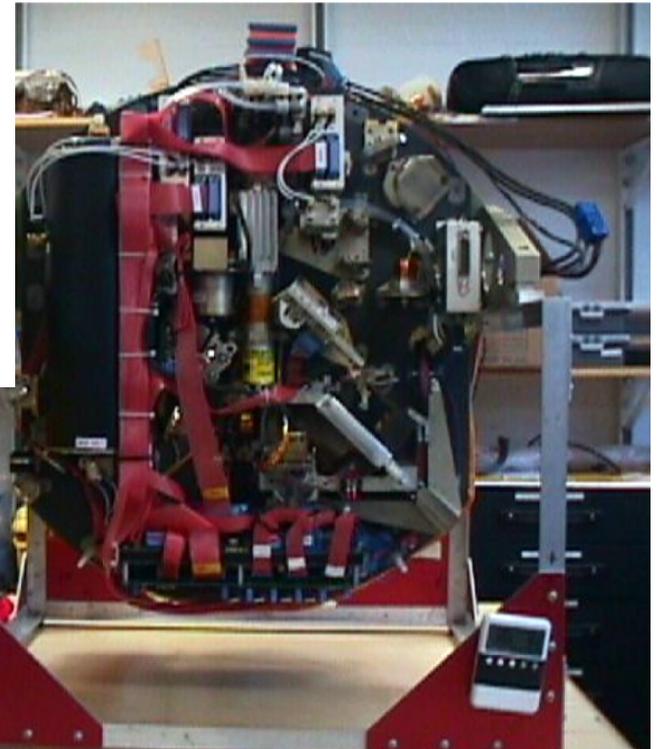
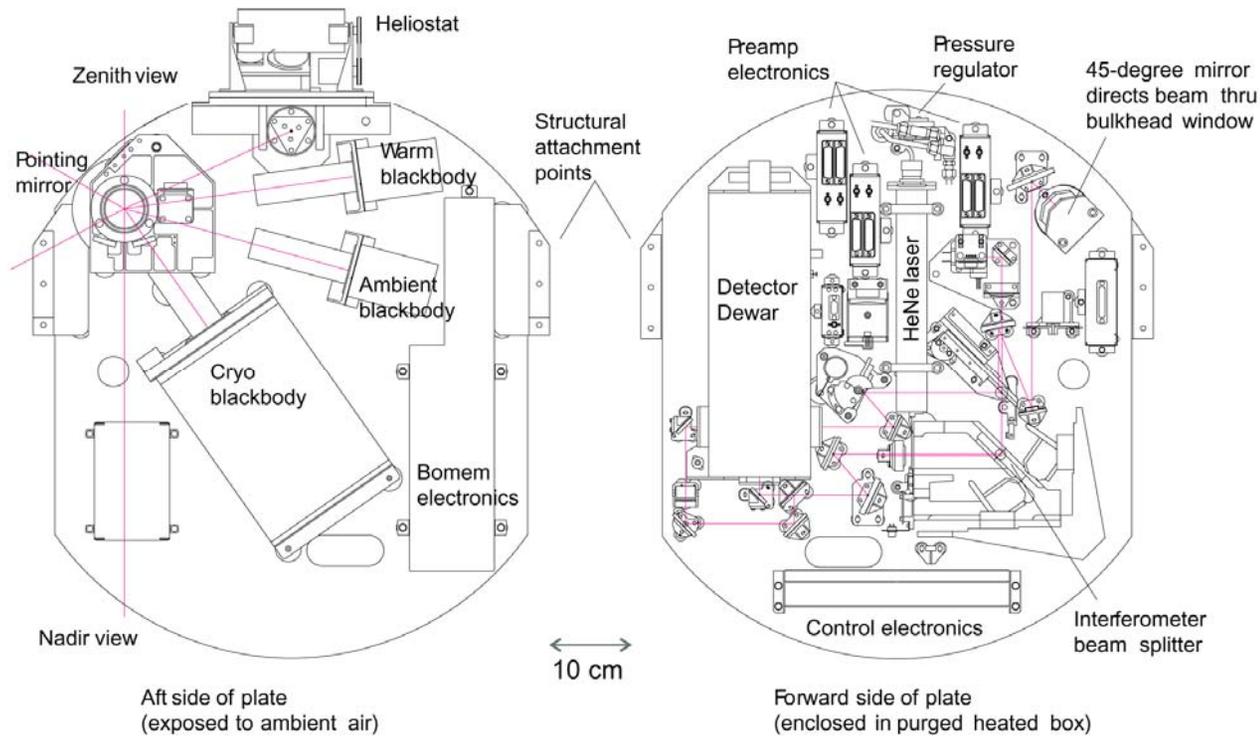




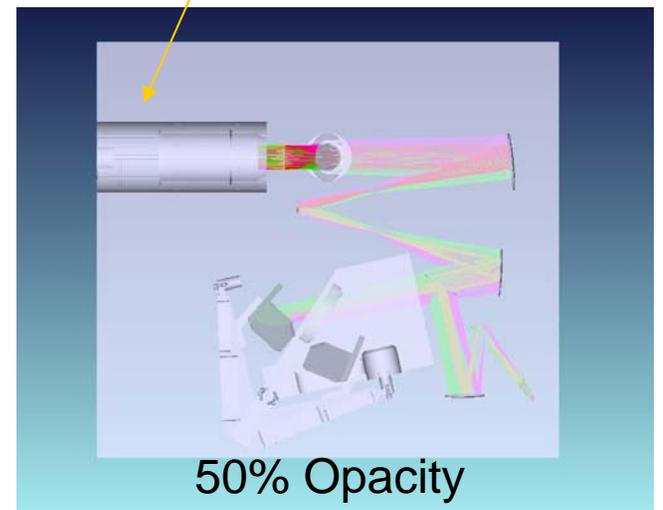
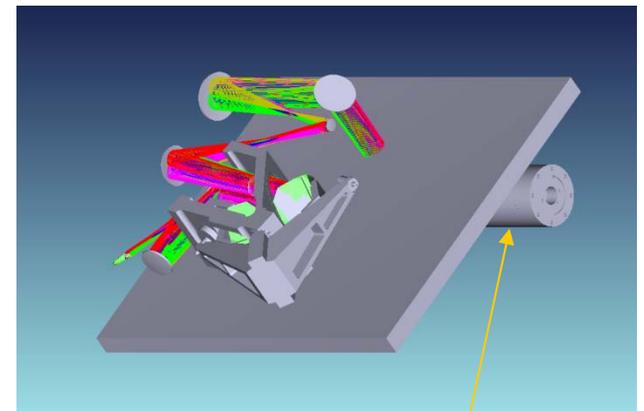
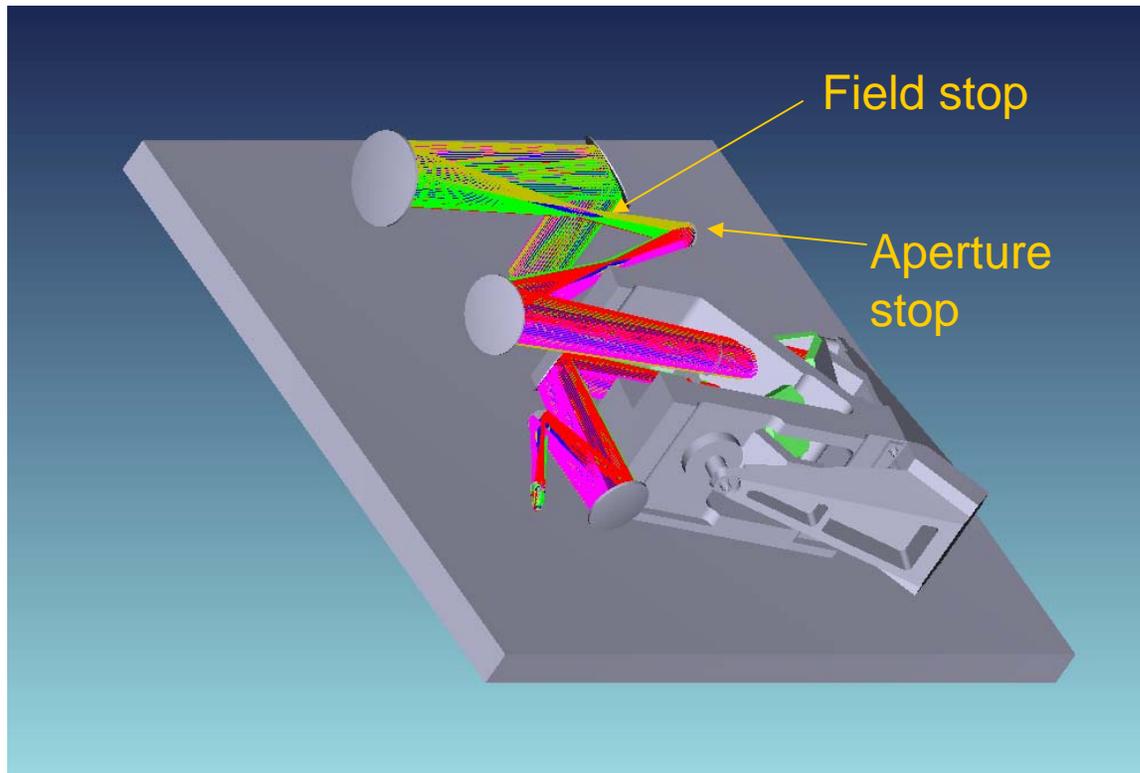
Top View

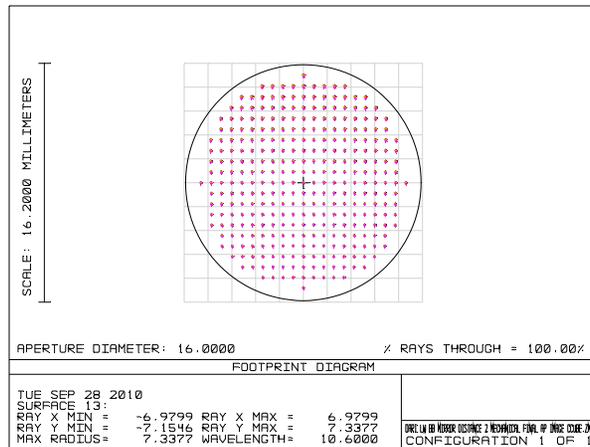
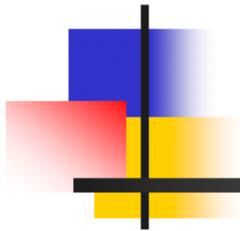


Side View

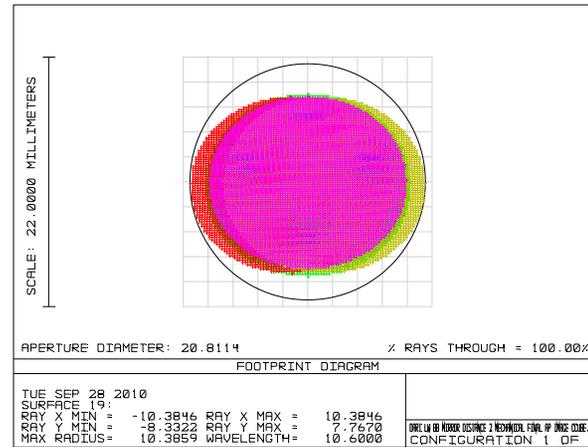


1. Keith, DW, JA Dykema, H Hu, L Lapon, and JG Anderson, 2001: *App. Opt.* **40**(30) 5463
2. Keith, DW, Anderson, JG. 2001: *J. Climate* **14** 979

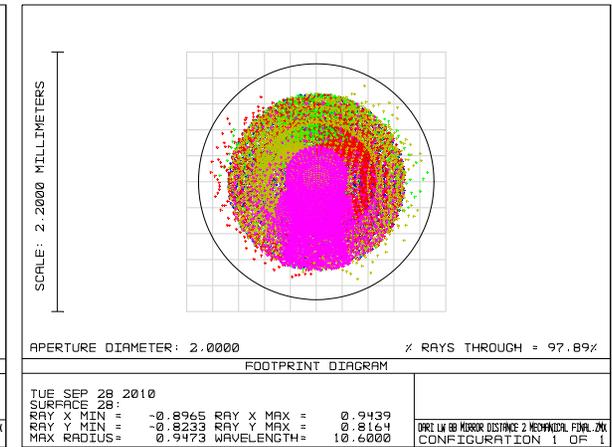




Footprint at aperture stop



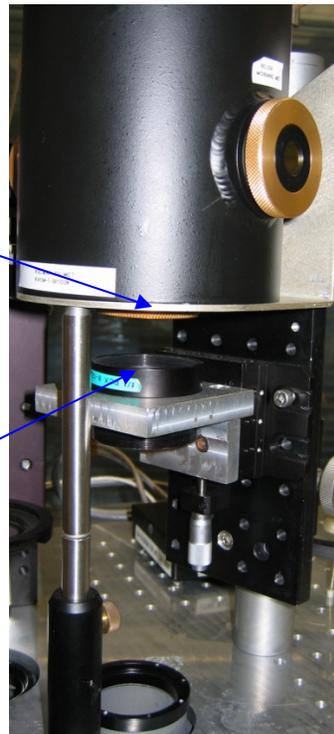
Footprint at corner cube



Footprint at far-IR detector

Cooled detector

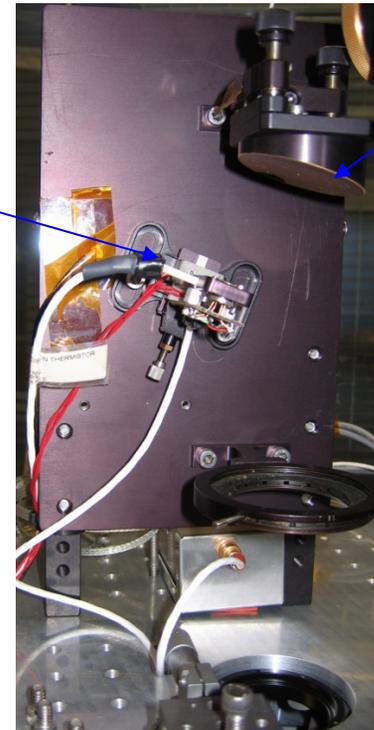
Refractive aft optics



MCT detector

Uncooled detector

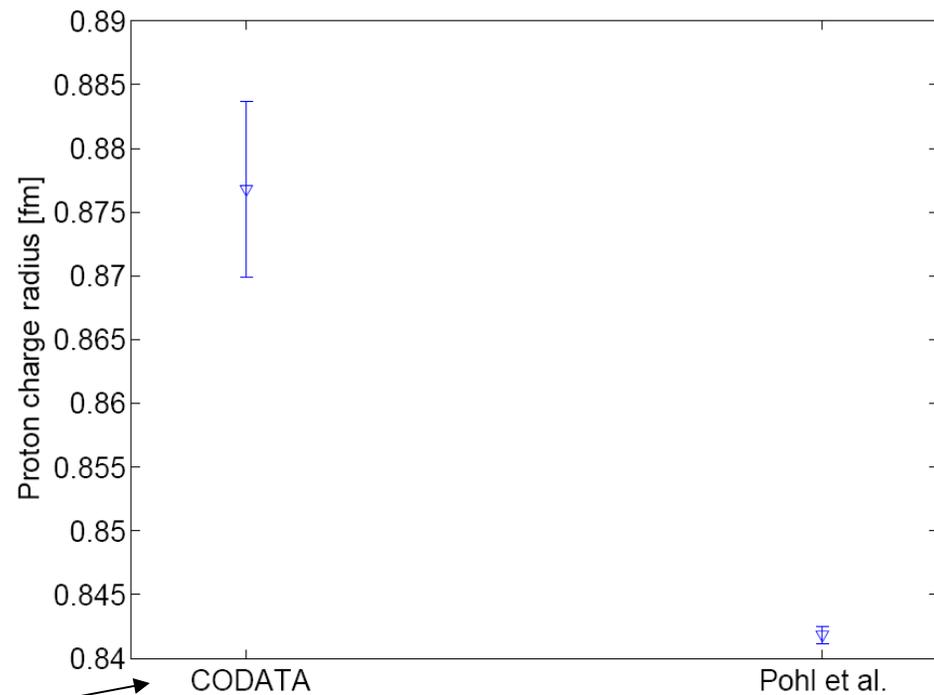
Reflective aft optics



Pyroelectric detector

Even today,
unpleasant
surprises still
happen!

Accepted
international value
of proton radius



New measurements made in
different conditions for lower
uncertainty (2010)

- Thanks to
 - Harvard: Stephen Leroy, Yi Huang
 - NIST: Sergey Mekhontsev, Leonard Hanssen, Eric Shirley, Jerry Fraser
 - UW: Hank Revercomb, Fred Best, Jon Gero, Joe Taylor, Bob Knuteson, Dave Tobin
 - LaRC: Dave Young, Marty Mlynczak, Bruce Wielicki, Dave Johnon, Alan Little
 - David Keith, Eric Cornell